

N-Channel Enhancement Mode

Low Q_g and R_g

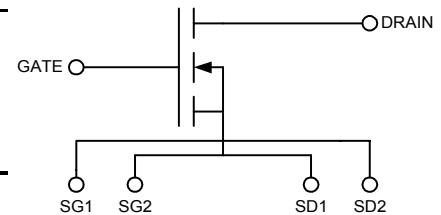
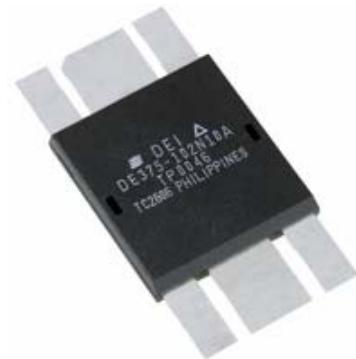
High dv/dt

Nanosecond Switching

Symbol	Test Conditions	Maximum Ratings		
V_{DSS}	$T_J = 25^\circ C$ to $150^\circ C$	1000	V	
V_{DGR}	$T_J = 25^\circ C$ to $150^\circ C$; $R_{GS} = 1 M\Omega$	1000	V	
V_{GS}	Continuous	± 20	V	
V_{GSM}	Transient	± 30	V	
I_{D25}	$T_c = 25^\circ C$	10	A	
I_{DM}	$T_c = 25^\circ C$, pulse width limited by T_{JM}	60	A	
I_{AR}	$T_c = 25^\circ C$	10	A	
E_{AR}	$T_c = 25^\circ C$	30	mJ	
dv/dt	$I_S \leq I_{DM}$, $di/dt \leq 100 A/\mu s$, $V_{DD} \leq V_{DSS}$, $T_j \leq 150^\circ C$, $R_G = 0.2\Omega$	5	V/ns	
	$I_S = 0$	>200	V/ns	
P_{DC}		940	W	
P_{DHS}	$T_c = 25^\circ C$ Derate 4.4W/ $^\circ C$ above $25^\circ C$	425	W	
P_{DAMB}	$T_c = 25^\circ C$	4.5	W	
R_{thJC}		0.16	C/W	
R_{thJHS}		0.23	C/W	

Symbol	Test Conditions	Characteristic Values		
		min.	typ.	max.
V_{DSS}	$V_{GS} = 0 V$, $I_D = 3 ma$	1000		V
$V_{GS(th)}$	$V_{DS} = V_{GS}$, $I_D = 4 ma$	2.5		5.5 V
I_{GSS}	$V_{GS} = \pm 20 V_{DC}$, $V_{DS} = 0$		± 100	nA
I_{DSS}	$V_{DS} = 0.8 V_{DSS}$ $T_J = 25^\circ C$ $V_{GS} = 0$ $T_J = 125^\circ C$		50 1	μA mA
$R_{DS(on)}$	$V_{GS} = 15 V$, $I_D = 0.5I_{D25}$ Pulse test, $t \leq 300\mu s$, duty cycle d $\leq 2\%$			1.2 Ω
g_{fs}	$V_{DS} = 15 V$, $I_D = 0.5I_{D25}$, pulse test	6	18	S
T_J		-55		+150 $^\circ C$
T_{JM}			150	$^\circ C$
T_{stg}		-55		+150 $^\circ C$
T_L	1.6mm (0.063 in) from case for 10 s	300		$^\circ C$
Weight		3		g

$$\begin{aligned}V_{DSS} &= 1000 \text{ V} \\I_{D25} &= 10 \text{ A} \\R_{DS(on)} &= 1.2 \Omega \\P_{DC} &= 940 \text{ W}\end{aligned}$$



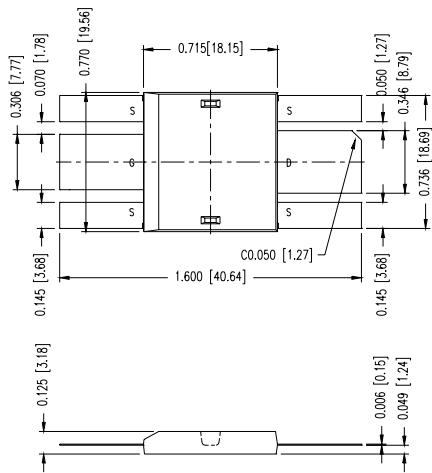
Features

- Isolated Substrate
 - high isolation voltage (>2500V)
 - excellent thermal transfer
 - Increased temperature and power cycling capability
- IXYS advanced low Q_g process
- Low gate charge and capacitances
 - easier to drive
 - faster switching
- Low $R_{DS(on)}$
- Very low insertion inductance (<2nH)
- No beryllium oxide (BeO) or other hazardous materials

Advantages

- Optimized for RF and high speed switching at frequencies to 50MHz
- Easy to mount—no insulators needed
- High power density

Symbol	Test Conditions	Characteristic Values (T _J = 25°C unless otherwise specified)		
		min.	typ.	max.
R _G		0.3	Ω	
C _{iss}		2900	pF	
C _{oss}	V _{GS} = 0 V, V _{DS} = 0.8 V _{DSS(max)} , f = 1 MHz	100	pF	
C _{rss}		25	pF	
C _{stray}	Back Metal to any Pin	33	pF	
T _{d(on)}		5	ns	
T _{on}	V _{GS} = 15 V, V _{DS} = 0.8 V _{DSS} I _D = 0.5 I _{DM}	3	ns	
T _{d(off)}	R _G = 0.2 Ω (External)	5	ns	
T _{off}		8	ns	
Q _{g(on)}		90	nC	
Q _{gs}	V _{GS} = 10 V, V _{DS} = 0.5 V _{DSS} I _D = 0.5 I _{D25}	30	nC	
Q _{gd}		40	nC	



Symbol	Test Conditions	Characteristic Values (T _J = 25°C unless otherwise specified)		
		min.	typ.	max.
I _S	V _{GS} = 0 V		10	A
I _{SM}	Repetitive; pulse width limited by T _{JM}		80	A
V _{SD}	I _F = I _S , V _{GS} = 0 V, Pulse test, t ≤ 300 μs, duty cycle ≤ 2%		1.5	V
T _{rr}		200	ns	
Q _{RM}	I _F = I _S , -di/dt = 100A/μs, V _R = 100V	0.6	μC	
I _{RM}		7	A	

(1) These parameters apply to the package, not individual MOSFET devices.

For detailed device mounting and installation instructions, see the "DE-Series MOSFET Mounting Instructions" technical note on IXYS RF's web site at www.ixysrf.com/Technical_Support/App_notes.html

IXYS RF reserves the right to change limits, test conditions and dimensions.

IXYS RF MOSFETs are covered by one or more of the following U.S. patents:

4,835,592	4,850,072	4,881,106	4,891,686	4,931,844	5,017,508
5,034,796	5,049,961	5,063,307	5,187,117	5,237,481	5,486,715
5,381,025	5,640,045				

102N10A DE-SERIES SPICE Model

The DE-SERIES SPICE Model is illustrated in Figure 1. The model is an expansion of the SPICE level 3 MOSFET model. It includes the stray inductive terms L_G , L_S and L_D . R_d is the $R_{DS(ON)}$ of the device, R_{ds} is the resistive leakage term. The output capacitance, C_{OSS} , and reverse transfer capacitance, C_{RSS} are modeled with reversed biased diodes. This provides a varactor type response necessary for a high power device model. The turn on delay and the turn off delay are adjusted via R_{on} and R_{off} .

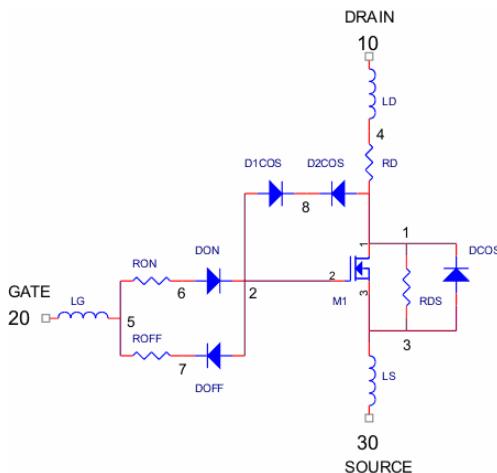


Figure 1 DE-SERIES SPICE Model

This SPICE model may be downloaded as a text file from the DEI web site at www.directedenergy.com/spice.htm

Net List:

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.SUBCKT 102N10A 10 20 30
* TERMINALS: D G S
* 1000 Volt 10 Amp 1.2 ohm N-Channel Power MOSFET
* REV.A 05-23-00
M1 1 2 3 3 DMOS L=1U W=1U
RON 5 6 0.5
DON 6 2 D1
ROF 5 7 .1
DOF 2 7 D1
D1CRS 2 8 D2
D2CRS 1 8 D2
CGS 2 3 3.0N
RD 4 1 1.5
DCOS 3 1 D3
RDS 1 3 5.0MEG
LS 3 30 .5N
LD 10 4 1N
LG 20 5 1N
.MODEL DMOS NMOS (LEVEL=3 VTO=3.0 KP=3.8)
.MODEL D1 D (IS=.5F CJO=1P BV=100 M=.5 VJ=.6 TT=1N)
.MODEL D2 D (IS=.5F CJO=400P BV=1000 M=.4 VJ=.6 TT=400N RS=10M)
.MODEL D3 D (IS=.5F CJO=900P BV=1000 M=.3 VJ=.4 TT=400N RS=10M)
.ENDS

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